

**Search Notes**

Application/Control No.

10/566,986

Examiner

Jinhee J. Lee

Applicant(s)/Patent under  
Reexamination

TERADA

Art Unit

2831

**SEARCHED**

Class	Subclass	Date	Examiner
174	72a	9/2/2006	LEE
↓	68.3	↓	↓
↓	73.1	↓	↓

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
174	as above	9/2/2006	LEE

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
See text search attached	9/2/2006	LEE